

Search Notes

Application/Control No.

09/554,065

Examiner

Sy D. Luu

Applicant(s)/Patent under
Reexamination

MIYOSHI ET AL.

Art Unit

2174

SEARCHED

Class	Subclass	Date	Examiner
715	751-752, 758,780, 816,705, 710	1/23/2006	SL
715	968		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPAT US-PGPUB	1/23/2006	SL
Test Searches: 715/751-753,758,780,810,816,864- 866,700,705,709,710,733,744,961, 968 709/204-205	1/23/2006	SL
707/1,3,4,6,10 704/1-10 463/36-41	1/23/2006	SL